

RDS(ON),max.

2.1mΩ

Drain

Gate

TO-263-2L

Gate

Source

D^[2]

232A

Drain

Source

BV_{DSS}

40V

TO-220-3L

40V N-ch Power MOSFET

General Features

- Proprietary New Trench Technology
- $> R_{DS(ON),typ} = 1.65 m\Omega @V_{GS} = 10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- High efficiency DC/DC Converters
- Synchronous Rectification
- UPS Inverter

Ordering Information

Part Number	Package	Marking		
FTP40N2P1L	TO-220-3L	40N2P1L		
FTB40N2P1L	TO-263-2L	40N2P1L		

Absolute Maximum Ratings

 $T_C {=} 25 ^{\circ} {\rm C}$ unless otherwise specified

Symbol	Parameter	Value	Unit	
V _{DSS}	Drain-to-Source Voltage ^[1]	40	- V	
V _{GSS}	Gate-to-Source Voltage	±20		
	Continuous Drain Current ^[2]	232		
Ι _D	Continuous Drain Current ^[3]	192	А	
	Continuous Drain Current at T_c =100 $^{\circ}C^{[2]}$	164	,,	
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2,4]	926	┨	
E _{AS}	Single Pulse Avalanche Energy $(V_{DD}=30V, V_{GS}=10V, R_G=25\Omega, L=1mH)$	250	mJ	
D	Power Dissipation	221	W	
PD	Derating Factor above 25℃	1.5	W/℃	
TL	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	°C	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 175	U	

Gate

Drain Source

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case			0.68	°C 1.11
R _{θJA}	Thermal Resistance, Junction-to-Ambient			63	°C/W

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Electrical Characteristics

OFF	Characteristics	
	Characteristics	

Parameter Drain-to-Source Breakdown Voltage Drain-to-Source Leakage Current Gate-to-Source Leakage Current acteristics Parameter Static Drain-to-Source	Min. 40 Min.	Тур.	Max. 1 ±100	Unit V uA	Test Conditions V _{GS} =0V, I _D =250uA V _{DS} =32V, V _{GS} =0V	
Drain-to-Source Leakage Current Gate-to-Source Leakage Current acteristics Parameter Static Drain-to-Source				uA		
Gate-to-Source Leakage Current acteristics Parameter Static Drain-to-Source	Min.				V _{DS} =32V, V _{GS} =0V	
Acteristics Parameter Static Drain-to-Source	Min.		±100	•		
Parameter Static Drain-to-Source	Min.	1		nA	V_{GS} =±20V, V_{DS} =0V	
Static Drain-to-Source	Min.			TJ=	25 $^\circ \!$	
		Тур.	Max.	Unit	Test Conditions	
		1.65	2.1	mΩ	V _{GS} =10V, I _D =80A ^[5]	
On-Resistance		2.0	2.5	mΩ	V _{GS} =4.5V, I _D =80A ^[5]	
Gate Threshold Voltage	1.0		3.0	V	$V_{DS}=V_{GS}$, $I_{D}=250$ uA	
ynamic Characteristics Essentially independent of operating tempe			ndent of operating temperature			
Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
Input Capacitance		5.4			V _{GS} =0V,	
Reverse Transfer Capacitance		0.31		nF	V _{DS} =25V,	
Output Capacitance		0.91			f=1.0MHz	
Gate Series Resistance		1.5		Ω	f=1.0MHz	
Total Gate Charge		63			V _{DD} =20V, I _D =192A, V _{GS} =4.5V	
		115		nC	V/ -20V/	
Gate-to-Source Charge		15			V _{DD} =20V, I _D =192A, V _{GS} =10V	
Gate-to-Drain (Miller) Charge		34				
e Switching Characteristics		1	Essential	y indepe	ndent of operating temperature	
Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
Turn-on Delay Time		10			V _{DD} =20V	
Rise Time		24		no	$I_D = 182A$ $V_{GS} = 10V$ $R_G = 2.5\Omega$	
Turn-off Delay Time		77		115		
Fall Time		23				
Drain Body Diode Characteristic	CS		-	T_=	25 $^\circ\mathbb{C}$ unless otherwise specified	
Parameter	Min	Тур.	Max.	Unit	Test Conditions	
Continuous Source Current ^[2]			232	А	Maximum Ratings	
Diode Forward Voltage		0.9	1.2	V	I _S =80A, V _{GS} =0V	
Reverse Recovery Time		58		ns	V _{GS} =0V	
Reverse Recovery Charge		47		nC	l _F =20A,di/dt=100A/µs	
	Characteristics Parameter Input Capacitance Reverse Transfer Capacitance Output Capacitance Gate Series Resistance Total Gate Charge Gate-to-Source Charge Gate-to-Drain (Miller) Charge Switching Characteristics Parameter Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time Drain Body Diode Characteristic Parameter Continuous Source Current ^[2] Diode Forward Voltage Reverse Recovery Time	Characteristics Parameter Min. Input Capacitance Reverse Transfer Capacitance Output Capacitance Gate Series Resistance Total Gate Charge Gate-to-Source Charge Gate-to-Drain (Miller) Charge Switching Characteristics Min. Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time Min Orain Body Diode Characteristics Min Continuous Source Current ^[2] Diode Forward Voltage Reverse Recovery Time	CharacteristicsParameterMin.Typ.Input Capacitance5.4Reverse Transfer Capacitance0.31Output Capacitance0.91Gate Series Resistance1.5Total Gate Charge63Total Gate Charge15Gate-to-Source Charge15Gate-to-Drain (Miller) Charge34Switching CharacteristicsMin.Typ.Turn-on Delay Time10Rise Time24Turn-off Delay Time77Fall Time23Drain Body Diode CharacteristicsMinTyp.Continuous Source Current ^[2] 0.9Reverse Recovery Time58	CharacteristicsEssentialParameterMin.Typ.Max.Input Capacitance5.4Reverse Transfer Capacitance0.31Output Capacitance0.91Gate Series Resistance1.5Total Gate Charge63Total Gate Charge115Gate-to-Source Charge15Gate-to-Drain (Miller) Charge34Switching CharacteristicsEssentialParameterMin.Typ.Max.Turn-on Delay Time10Rise Time24Turn-off Delay Time77Fall Time23Drain Body Diode CharacteristicsYanMax.Continuous Source Current ^[2] 232Diode Forward Voltage0.91.2Reverse Recovery Time58	CharacteristicsEssentially indeperParameterMin.Typ.Max.UnitInput Capacitance 5.4 Input Capacitance 0.31 InFOutput Capacitance 0.91 InFInFInFOutput Capacitance 0.91 InFInFOutput Capacitance 1.5 Ω InFOutput Capacitance 1.5 Ω InCGate Series Resistance 1.5 Ω InCGate-to-Source Charge 15 InFGate-to-Drain (Miller) Charge 34 IntSwitching CharacteristicsEssentially indeperParameterMin.Typ.Max.Turn-on Delay Time 77 InsFall Time 23 InsOrain Body Diode Characteristics $T_J=7$ ParameterMinTyp.Max.ParameterMinTyp.Max.Inde Forward Voltage 0.9 1.2 VReverse Recovery Time 58 Ins	

Note:

[1] T_J=25℃ to 175℃

[2] Silicon limited current only

[3] Package limited current

[4] Repetitive rating, pulse width limited by maximum junction temperature.

[5] Pulse width≤380µs; duty cycle≤2%.



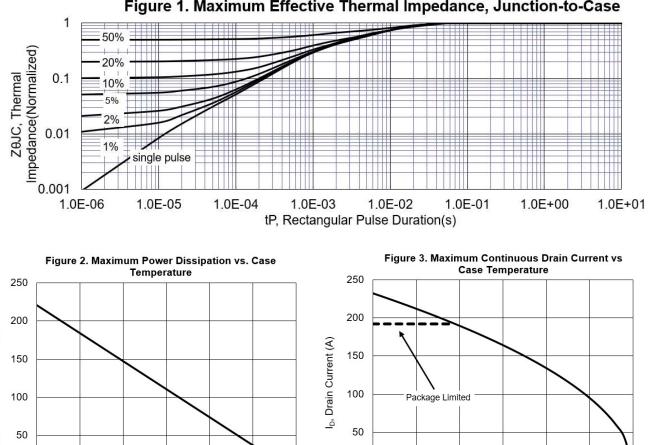
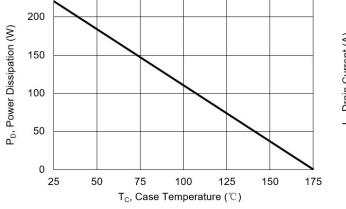
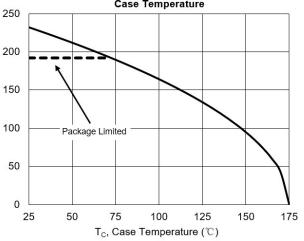
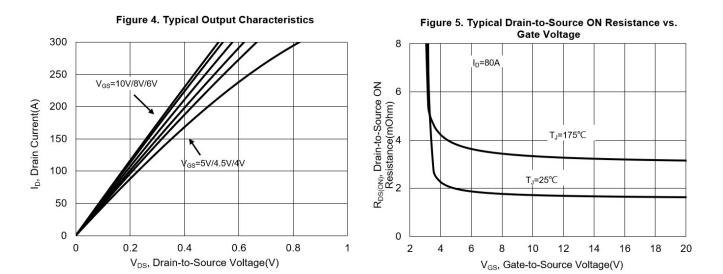


Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case









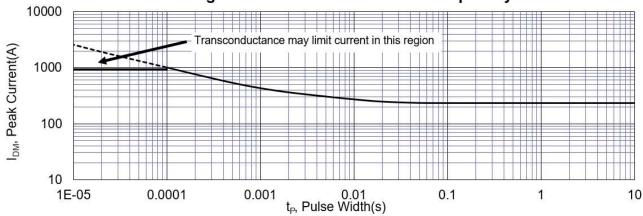


Figure 6. Maximum Peak Current Capability

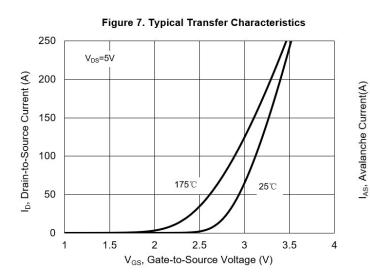
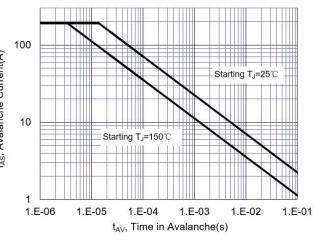
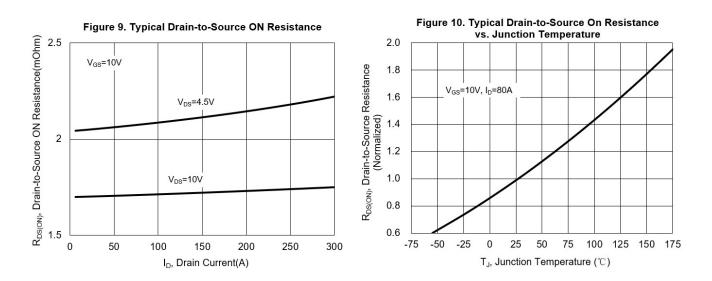


Figure 8. Unclamped Inductive Switching Capability

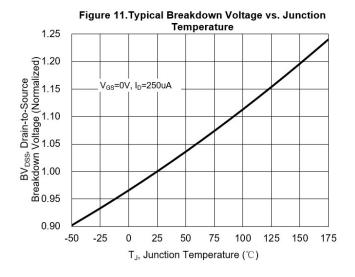




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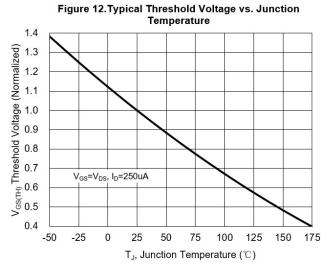


Figure 13. Maximum Forward Safe Operation Area

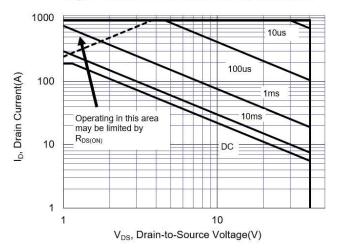
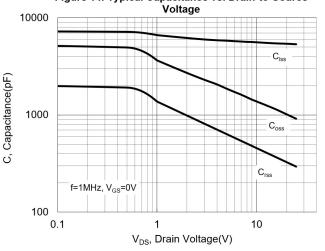
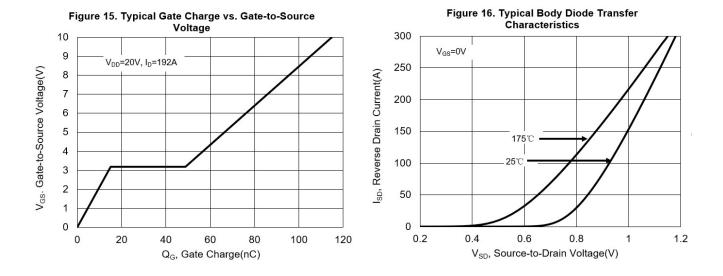


Figure 14. Typical Capacitance vs. Drain-to-Source



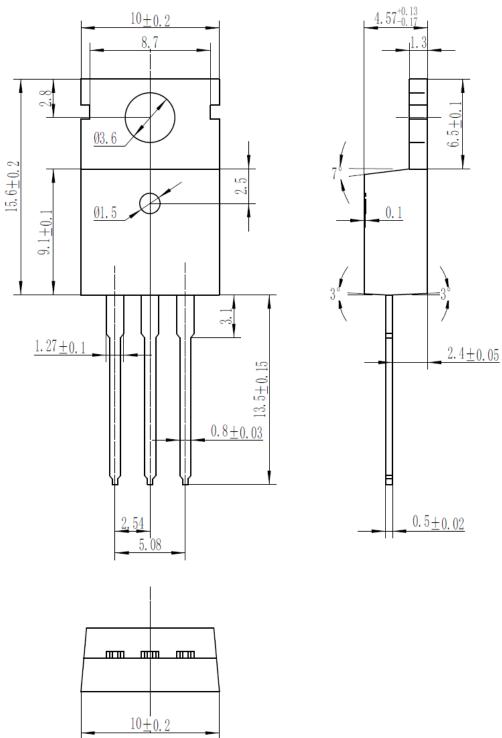


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Package Dimensions

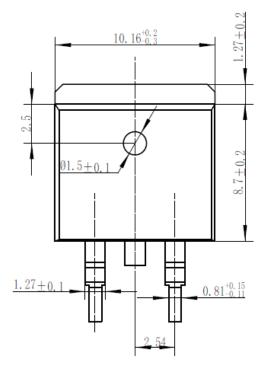
TO-220-3L

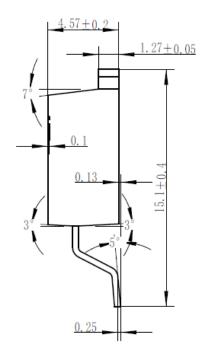


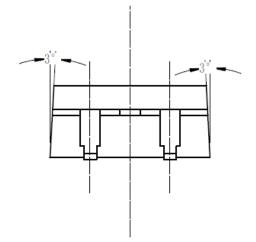




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